



Thermal Analysis of Beamline Components and Fatigue Design Criteria

presented by

S. Sharma

Contributors: V. Ravindranath, M. Givens, L. Zhang (ESRF)

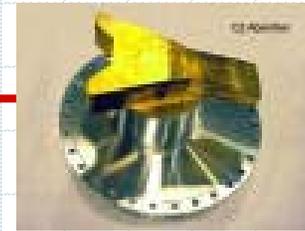
Outline



- Background
- Analysis Method
- Results of thermal analyses of beamline components
- Progress on fatigue design criteria
- Summary

Background

- All SR x-ray absorbers (right) were designed for 300 mA.
- Front-end and beamline components were designed for various current limits between 100 to 300 mA. Thermal analysis documentation is not readily available for many components.
- High current runs are on hold.
- Present design criteria are too conservative.



C2



W2



Beam Dump



TR5



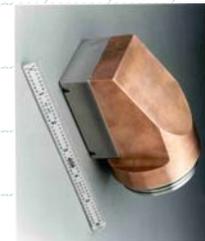
EA3



RF Taper



IEA6



Scraper

Background (contd.)



- **Goal I: Perform linear elastic finite element (FE) analyses using existing (highly conservative) design criteria to obtain upper limit on beam current.**

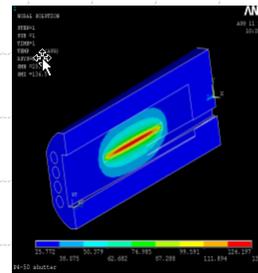
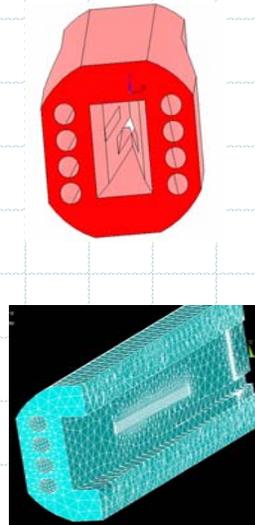
Design criteria:

- **Maximum temperature under the beam footprint should be less than 300 °C (for Glidcop).**
 - **Maximum stress is not to exceed yield stress (300-450 MPa for Glidcop)**
 - **Maximum temperature at the cooling channel wall should be less than the water boiling temperature (~ 145 °C).**
- **Goal II: Establish more realistic design criteria based on fatigue tests and nonlinear elastic-plastic finite element analyses.**

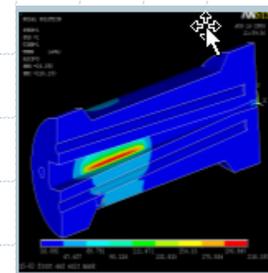
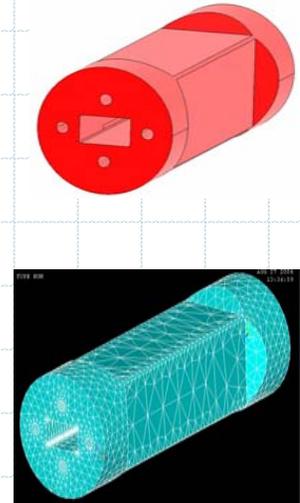
Analysis Method (Goal I)

- Beamline components were identified by M. Ramanathan.
- 2-D drawings were converted to Pro/E 3-D models by M. Givens (DD-ASD).
- 3-D models were transferred to Ansys in IGES format.
- Linear thermal and structural analyses were performed by V. Ravindranath (IIT) for beam power from Undulator A.
- Effects of assumptions (film coefficient, power distribution) were quantified.

P4-40 Shutter



L5-83 Mask



Beamline Components

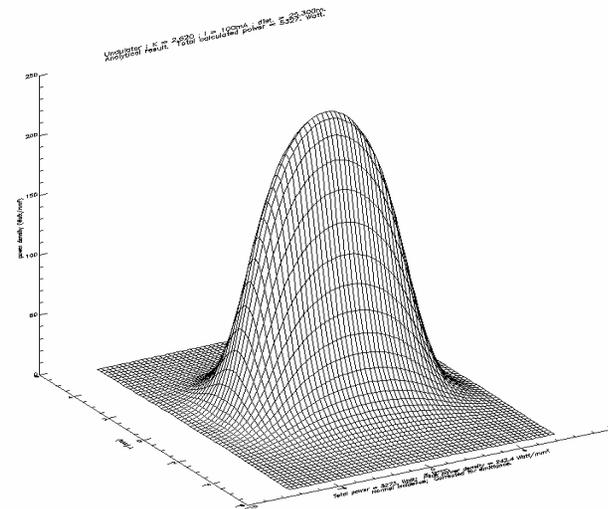


NO.	Component	Distance from the Undulator Source
1	L5-83: front-end exit mask for all version 1.2 front ends	25.3 m
2	M4-40: front-end exit mask on version 1.5 front-ends	25.3 m
3	M7-20: front-end exit mask for 4ID	25.3 m
4	M4-30: front-end exit mask	26 m
5	M7-41: beam-line splitter mask for 4ID	26 m
6	M9-30: white beam stop and pink beam mask	30 m
7	P5 Integral Shutter	30 m
8	P4-20: shutter	30 m
9	P4-31: shutter for 4ID	30 m
10	P4-50: shutter	30 m
11	P4-41: shutter for 4ID	60 m
12	K5-50: white beam stop for 4ID	77 m

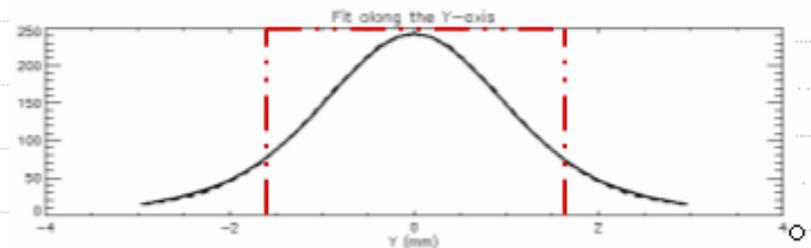
Analysis Method – Undulator Power

Undulator A

Parameter	Value
Beam current (mA)	100
Undulator period length λ (cm)	3.3
Length of undulator (m)	2.4
Minimum gap (mm)	11
Number of periods	72
Relativistic gamma	13700
Deflection parameter K	2.62
Horizontal beam size σ_x (mm)	0.352
Vertical beam size σ_y (mm)	0.018



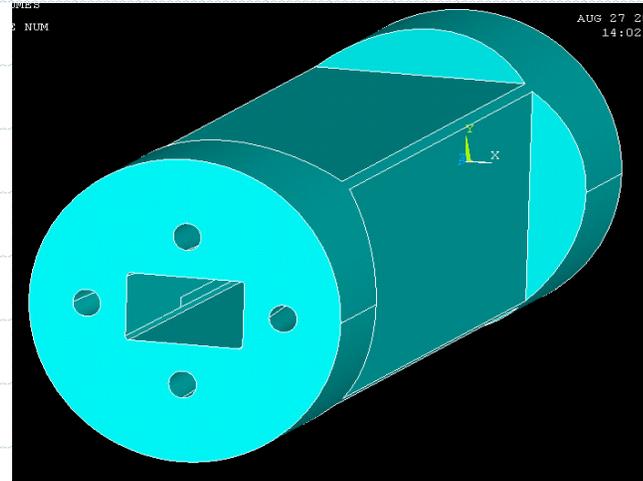
SRUFF Program



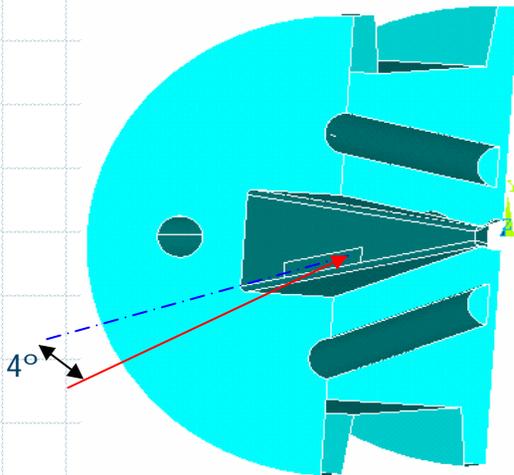
L5-83: Mask



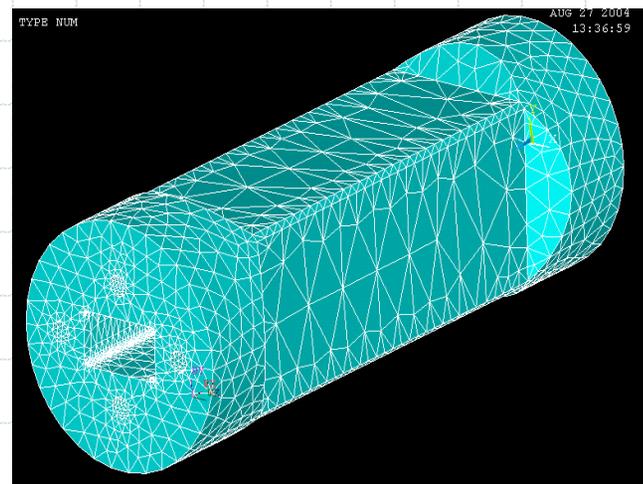
L5-83



L5-83 3-D model



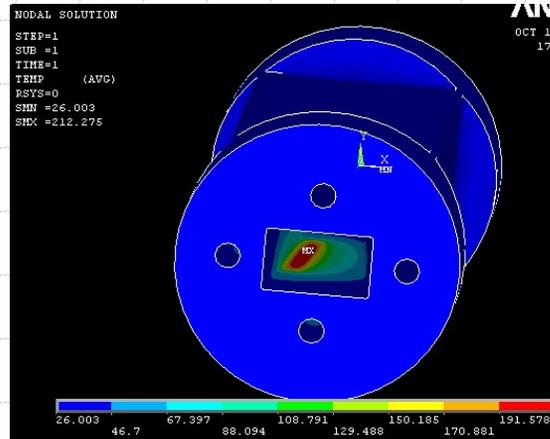
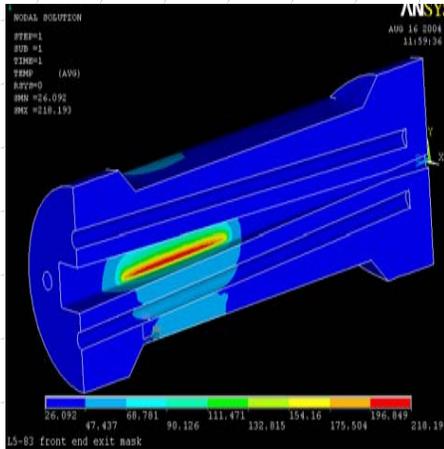
L5-83 Beam orientation



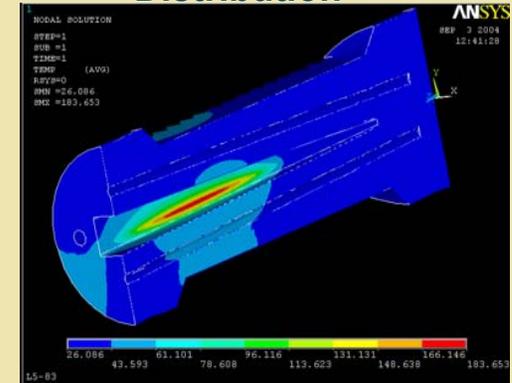
L5-83 FEA mesh

Results-Contour plots for L5-83

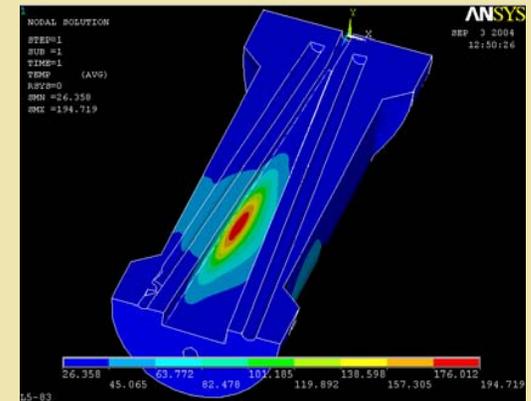
Case I : Uniform heat flux approximation



Case II & III : Gaussian Heat Flux Distribution



L5-83: Temperature Distribution for
Horizontal Deviation

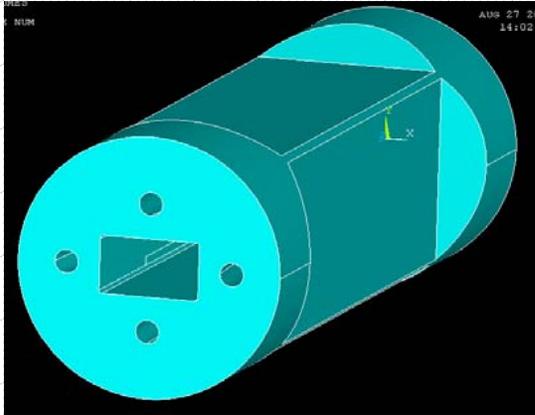


L5-83: Temperature Distribution for
Vertical Deviation

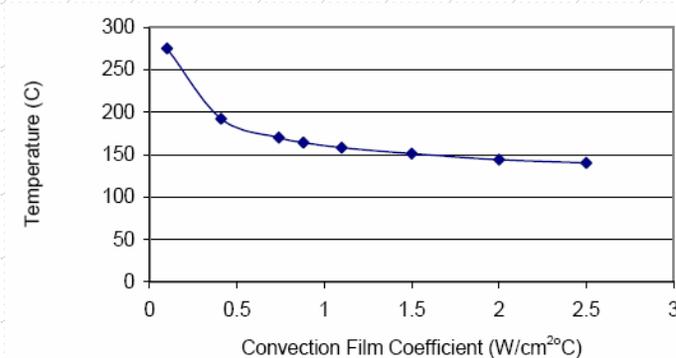
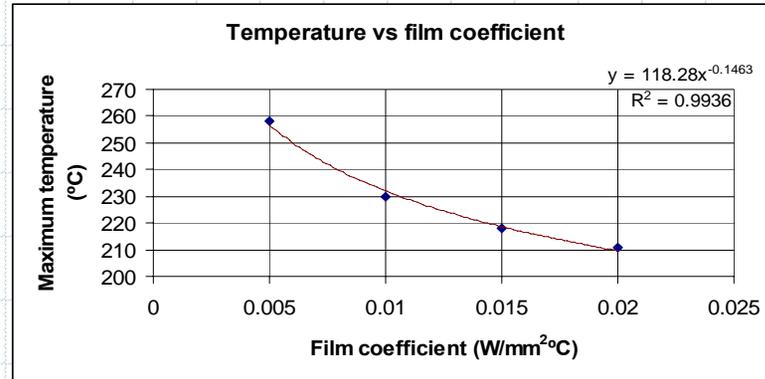
Beam Deviation	Maximum temperature (°C)	Difference
Horizontal: Gaussian/Uniform	184 / 218	18 %
Vertical: Gaussian/Uniform	195 / 212	9 %

Analysis Method — Film Coefficient

L5-83
Mask



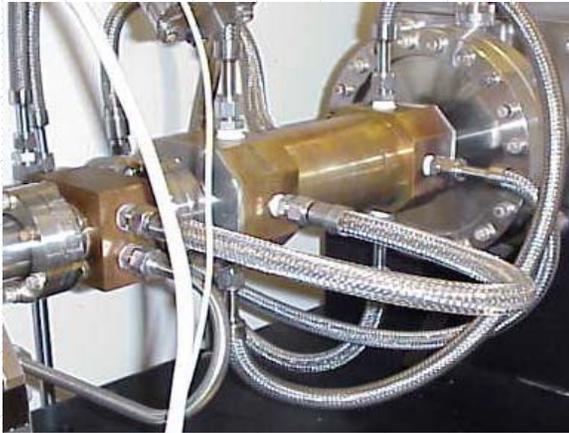
Crotch
Absorber



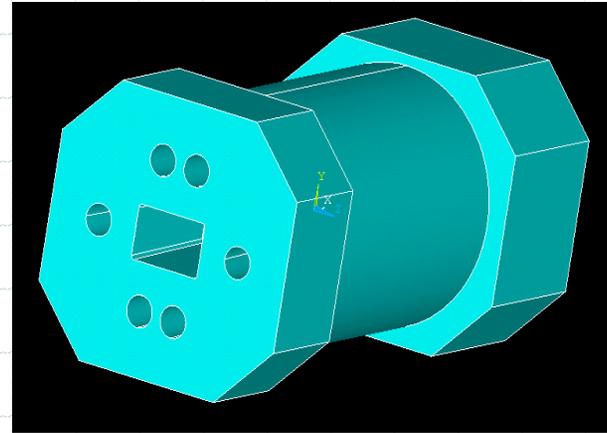
MEDSI02
pp. 431

A nominal value of 0.015 W/mm².°C for the film coefficient was used for all thermal analyses. The effect of cooling efficiency ($\pm 50\%$) on peak temperature is not significant.

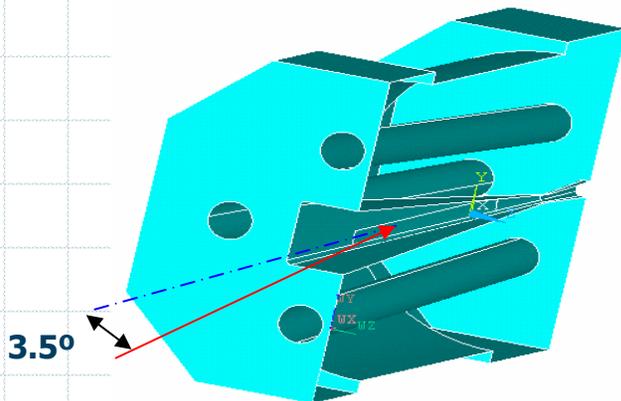
M4-40: Mask



M4-40

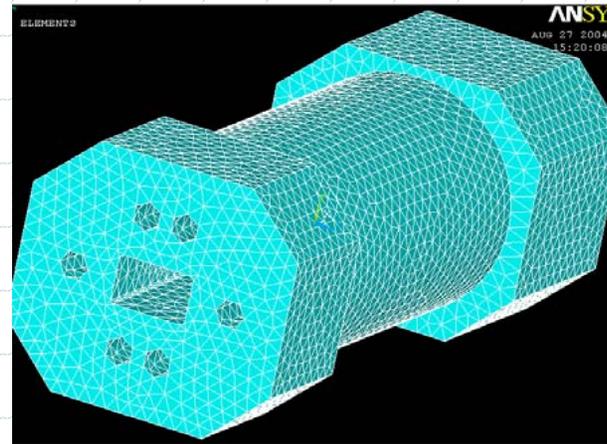


M4-40 3-D model



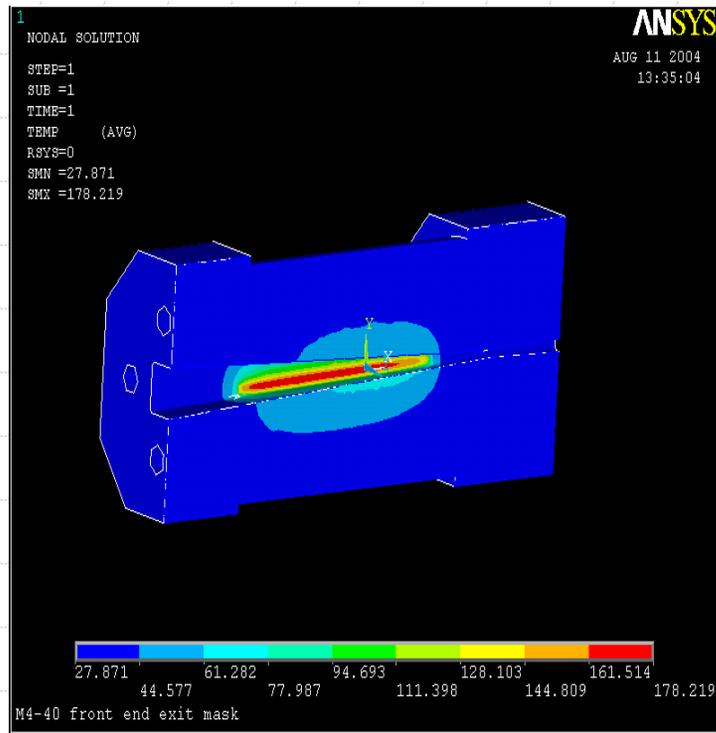
3.5°

M4-40 Beam orientation

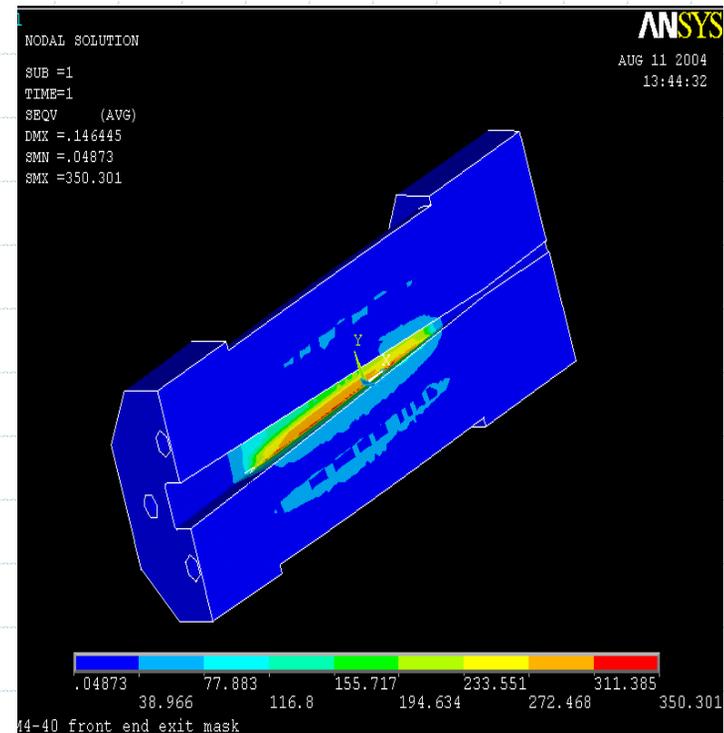


M4-40 FEA mesh

Results-contour plots for M4-40

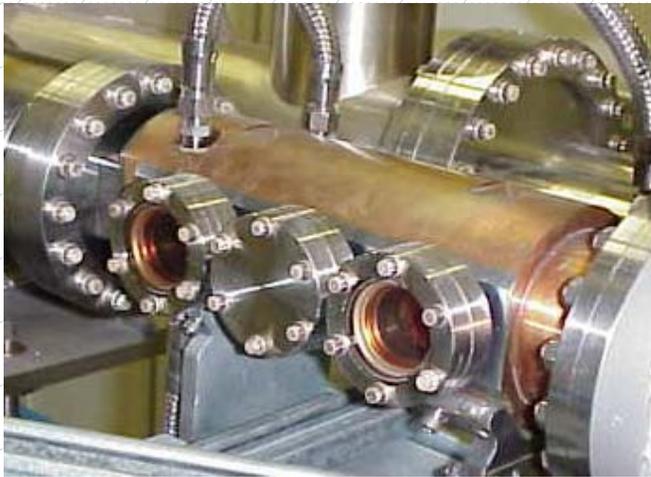


M4-40: Temperature Contours

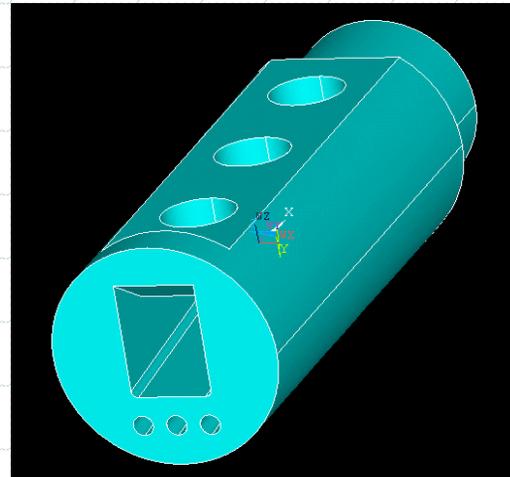


M4-40: von Mises Stress Contours

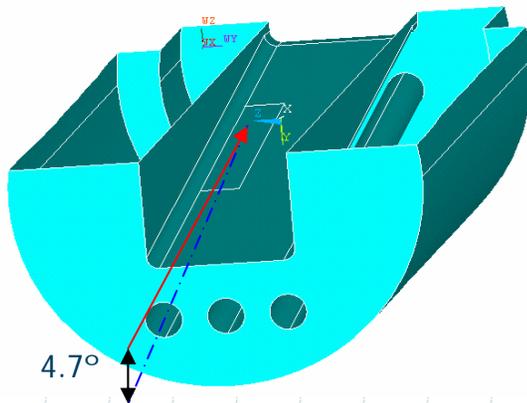
M9-30: Mask



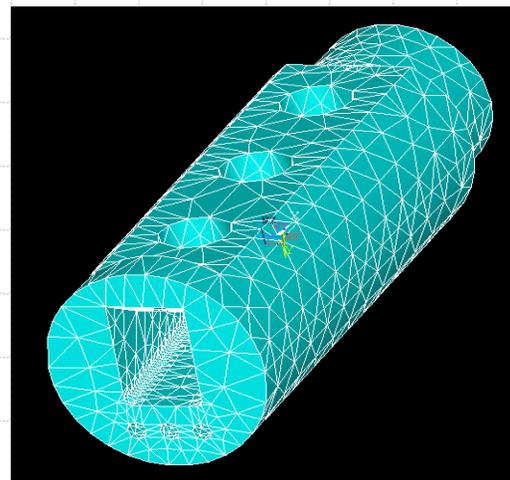
M9-30



M9-30 3-D model

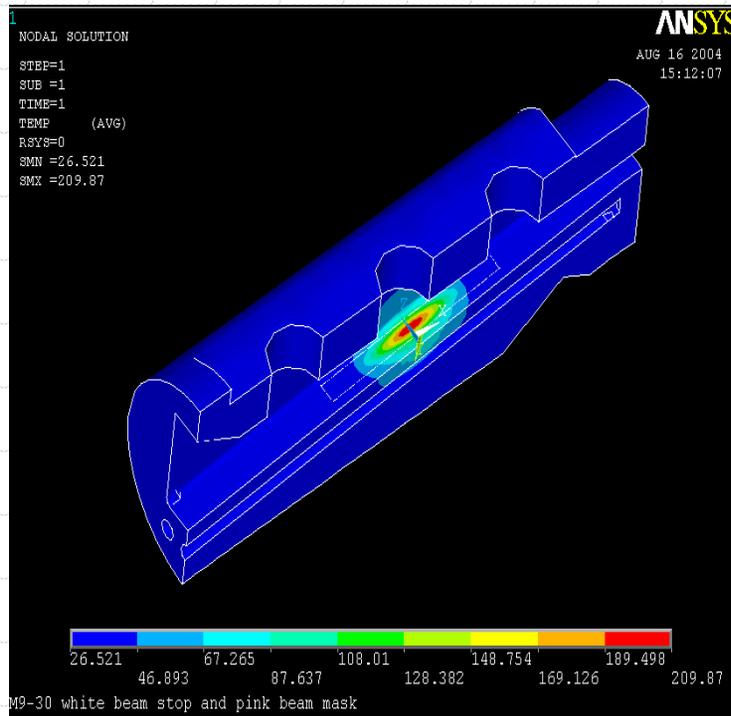


M9-30 Beam orientation

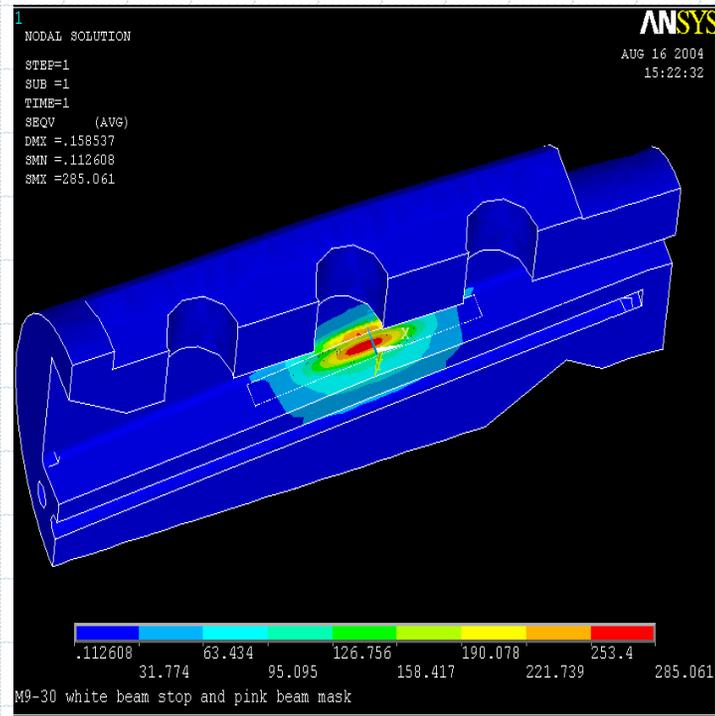


M9-30 FEA mesh

Results-contour plots for M9-30

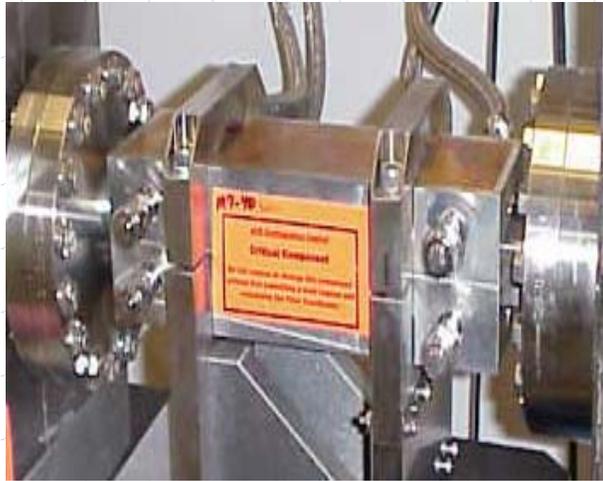


M9-30: Temperature distribution

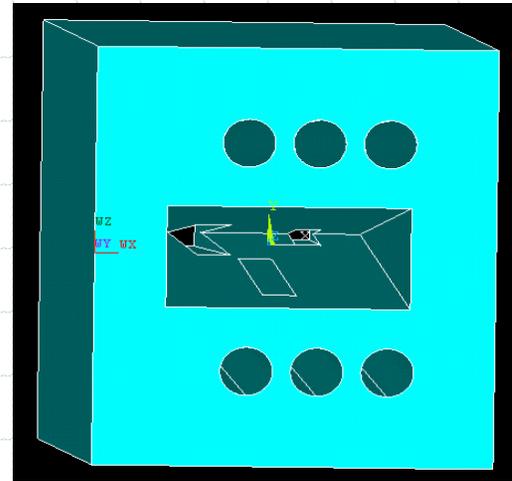


M9-30: von Mises stress distribution

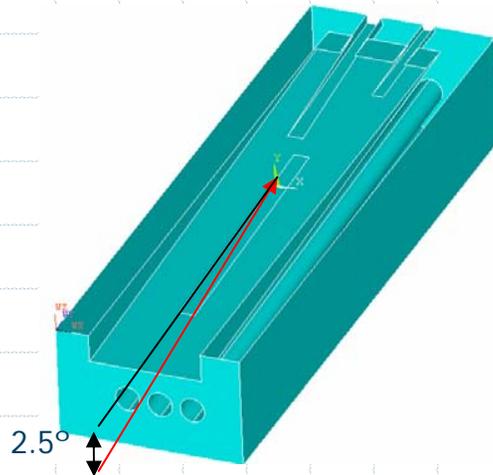
M7-40: Mask



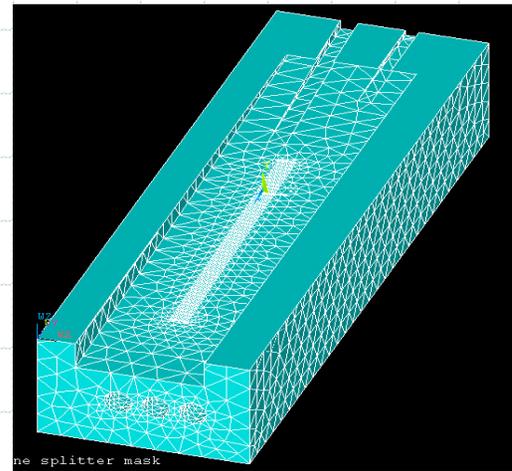
M7-40



M7-40 3-D model

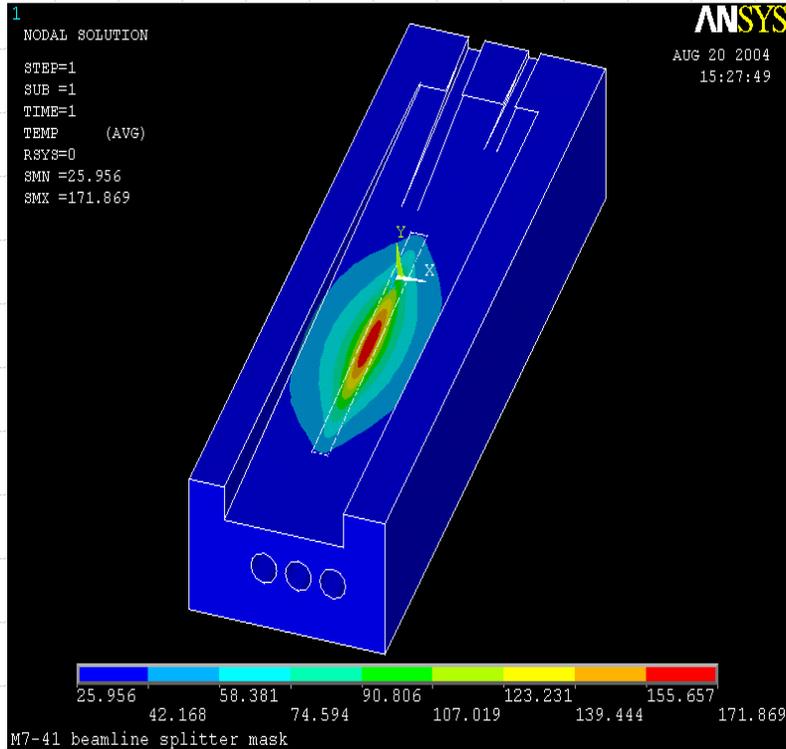


M7-40 Beam orientation

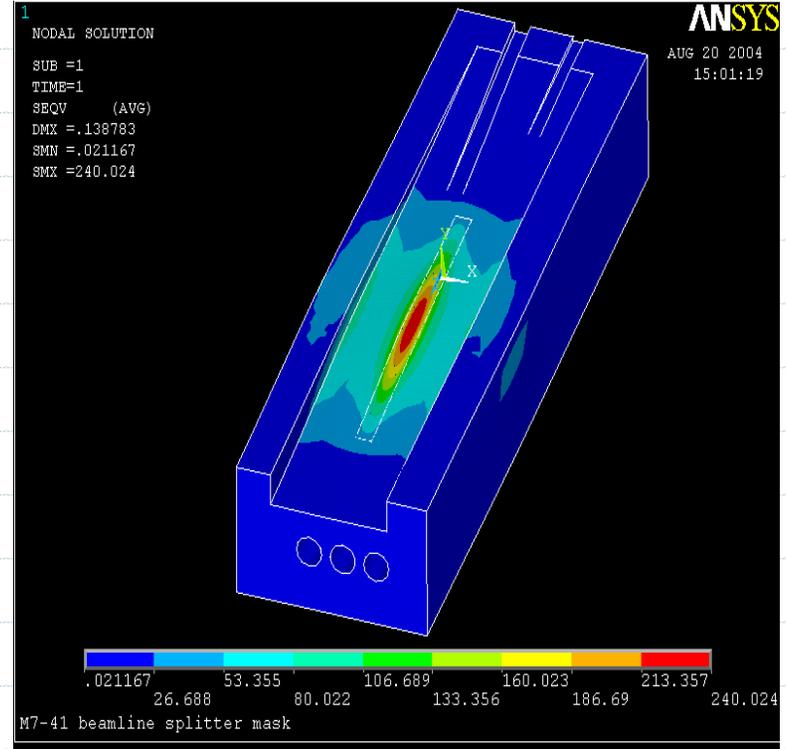


M7-40 FEA mesh

Results-contour plots for M7-40

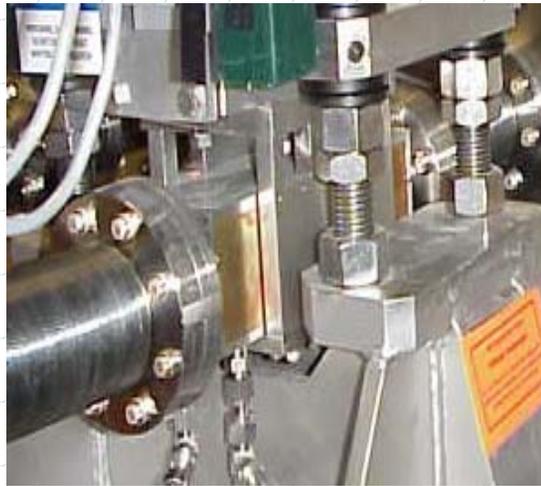


M7-40: Temperature Contours

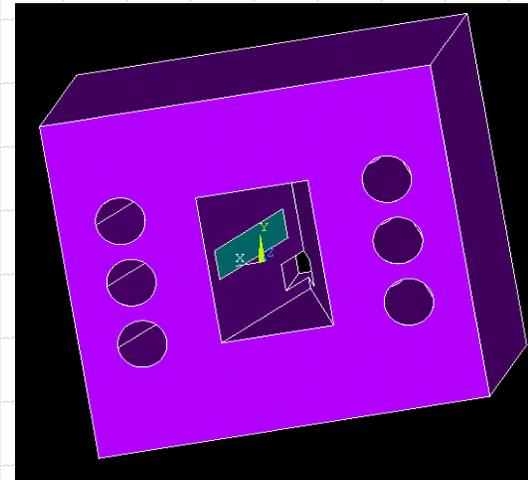


M7-40: von Mises stress Contours

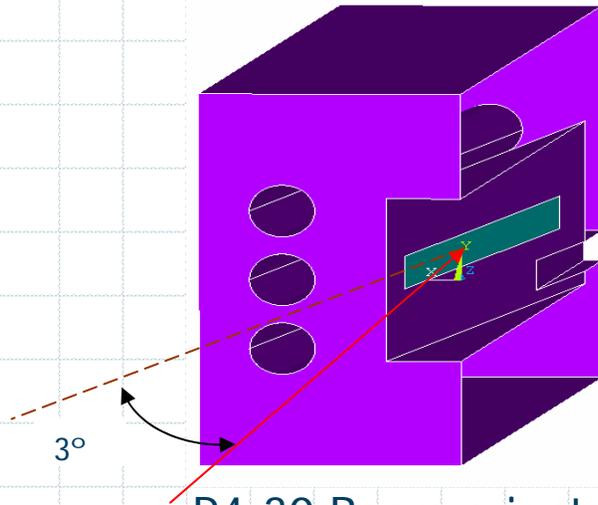
P4-30: Shutter



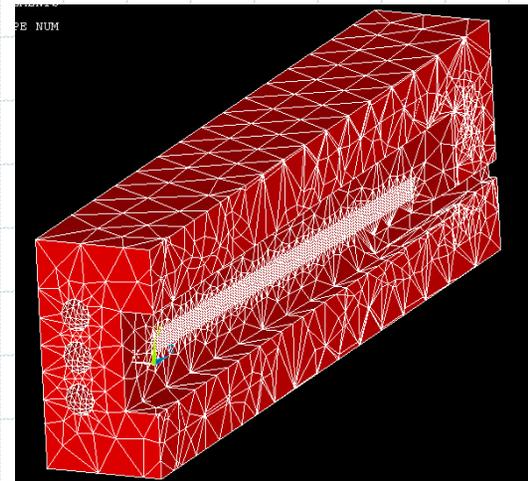
P4-30



P4-30 3-D model

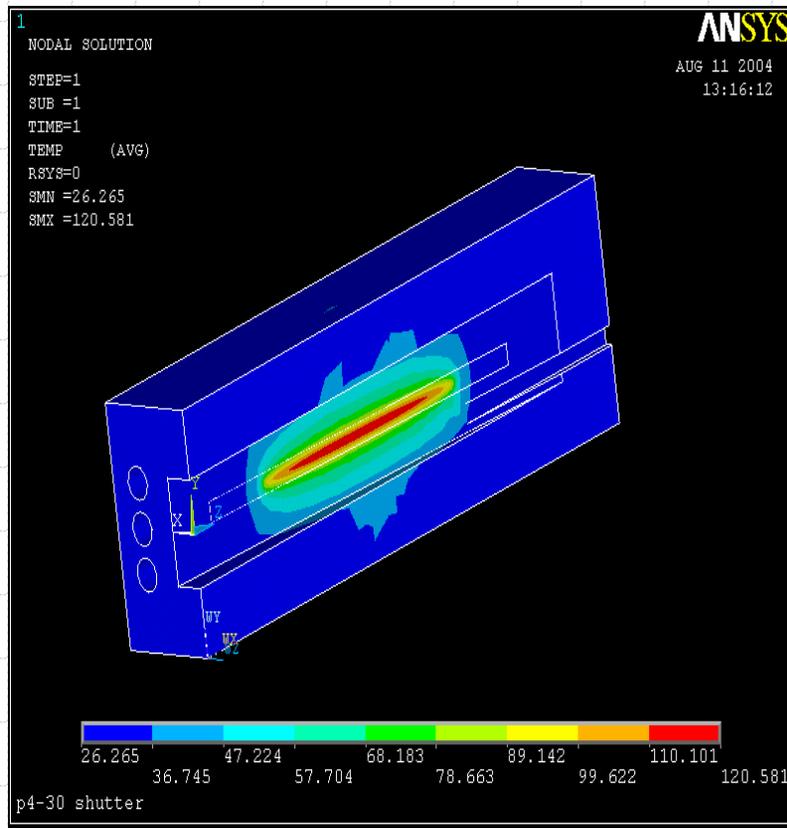


P4-30 Beam orientation

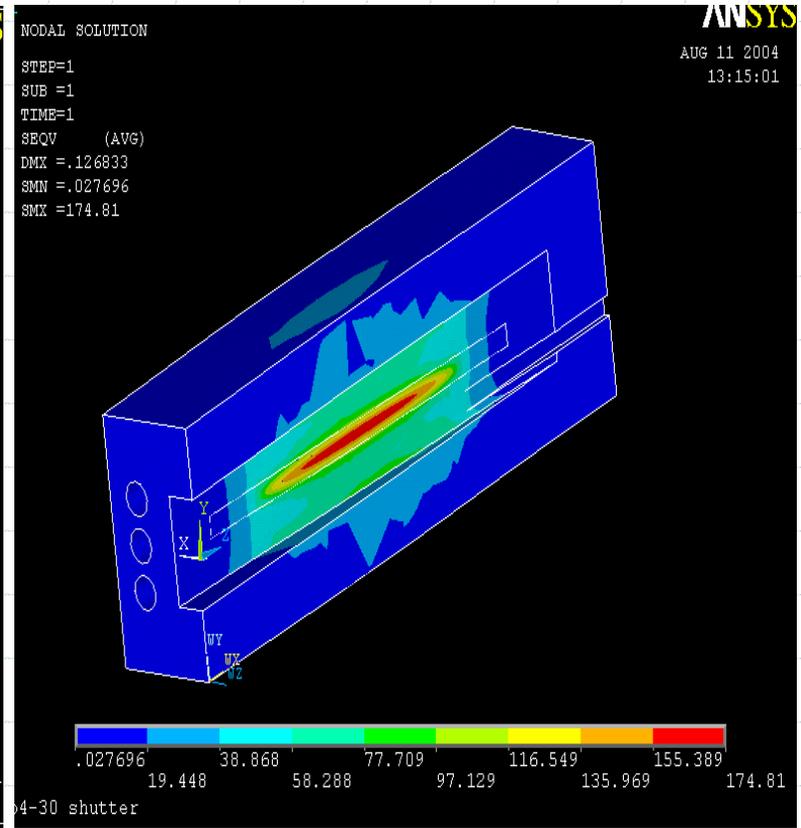


P4-30 FEA mesh

Results-contour plots for P4-30

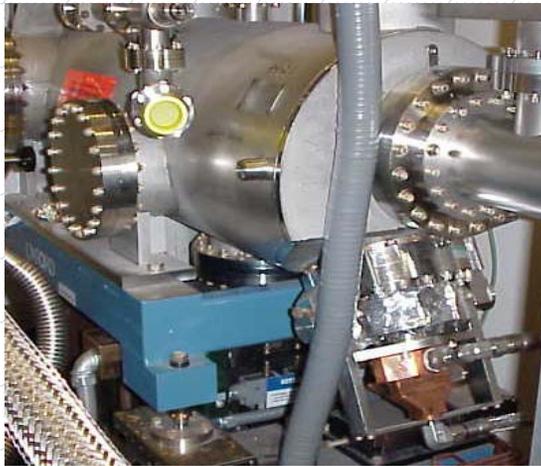


P4-30: Temperature Contours

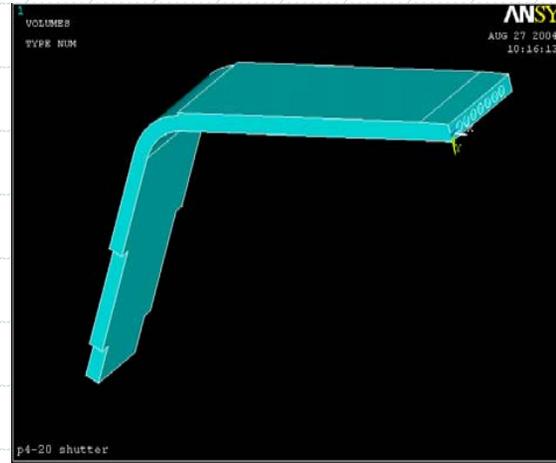


P4-30: von Mises Stress Contours

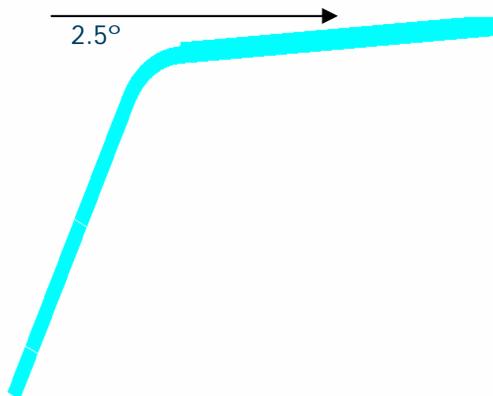
P4-20: Shutter



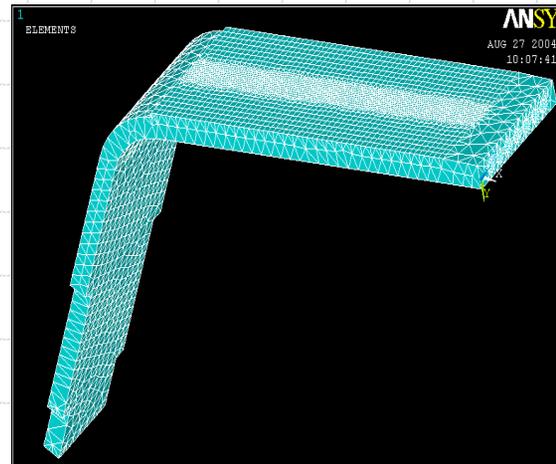
P4-20



P4-20 3-D model

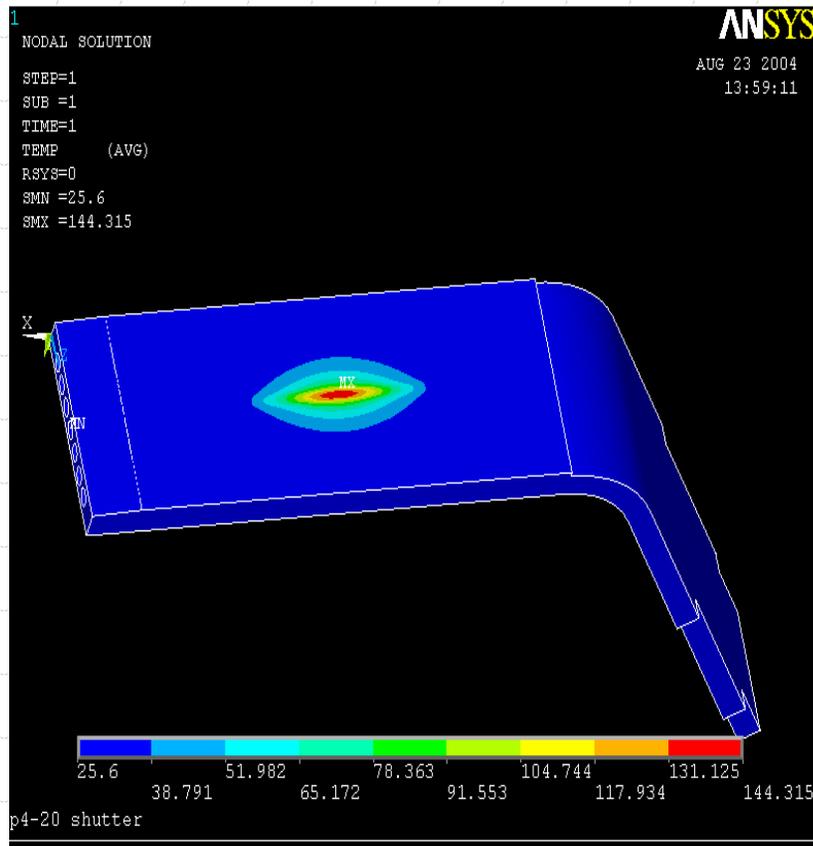


P4-20 Beam orientation

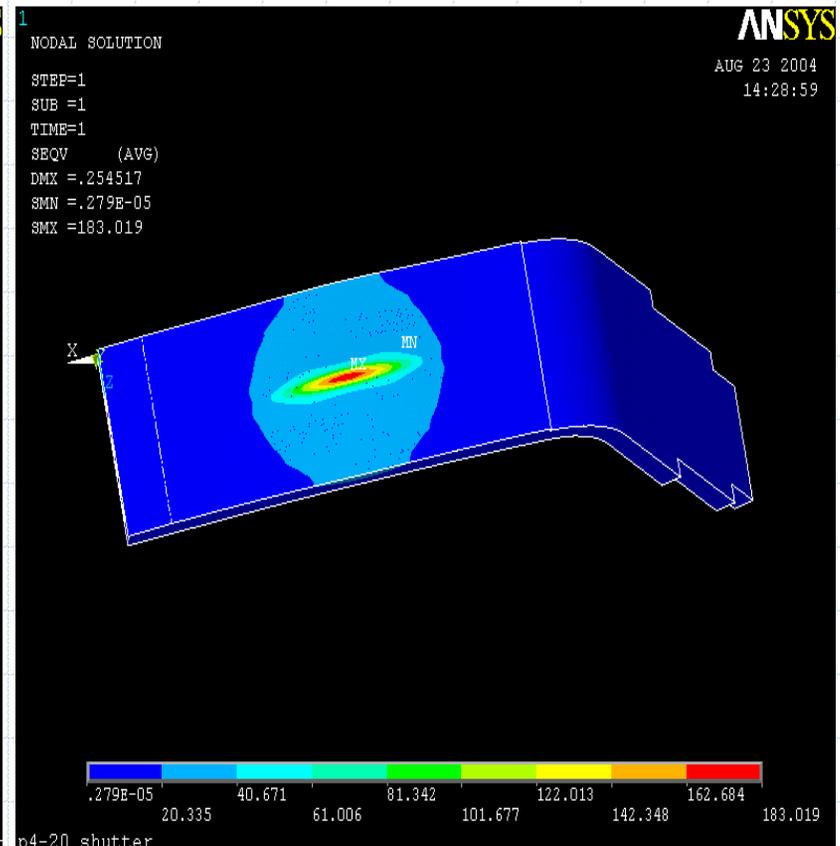


P4-20 FEA mesh

Results-contour plots for P4-20

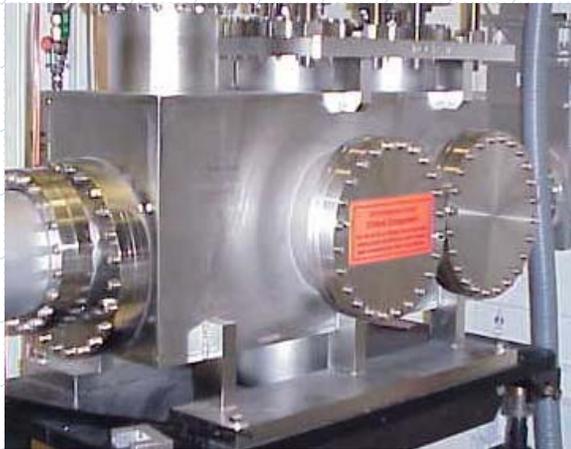


P4-20: Temperature Contours

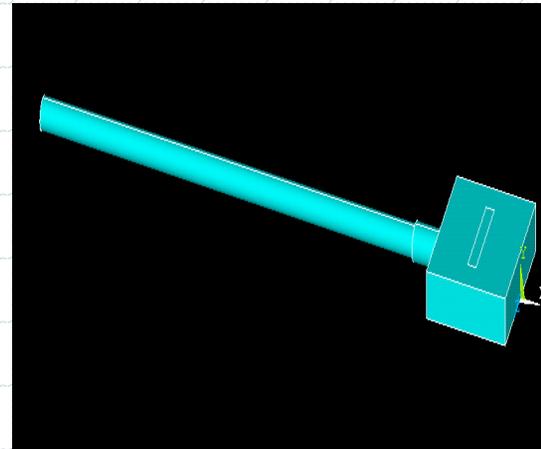


P4-20: von Mises Stress Contours

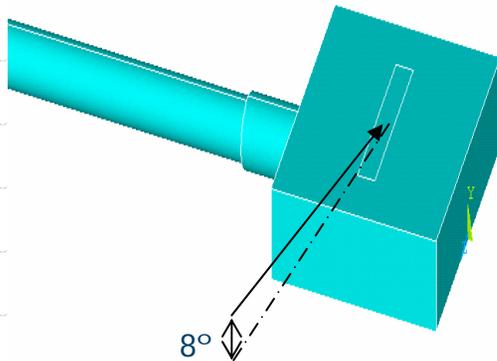
P4-40: Shutter



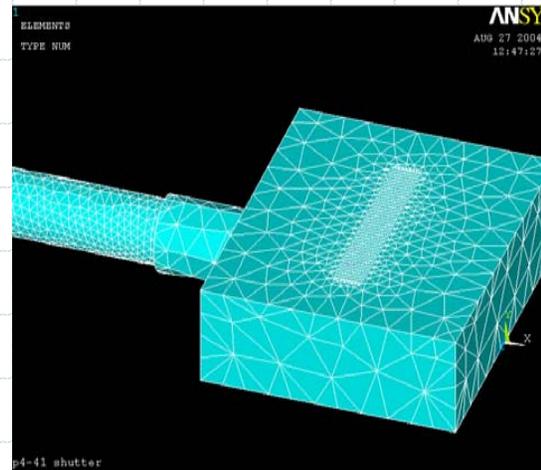
P4-40



P4-40 3-D model

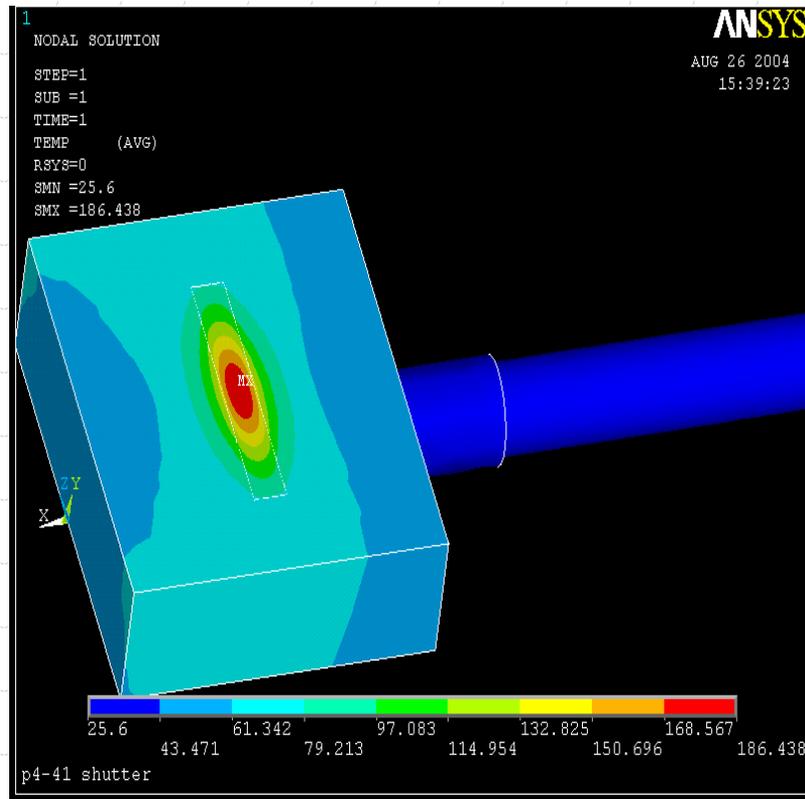


P4-40 Beam orientation

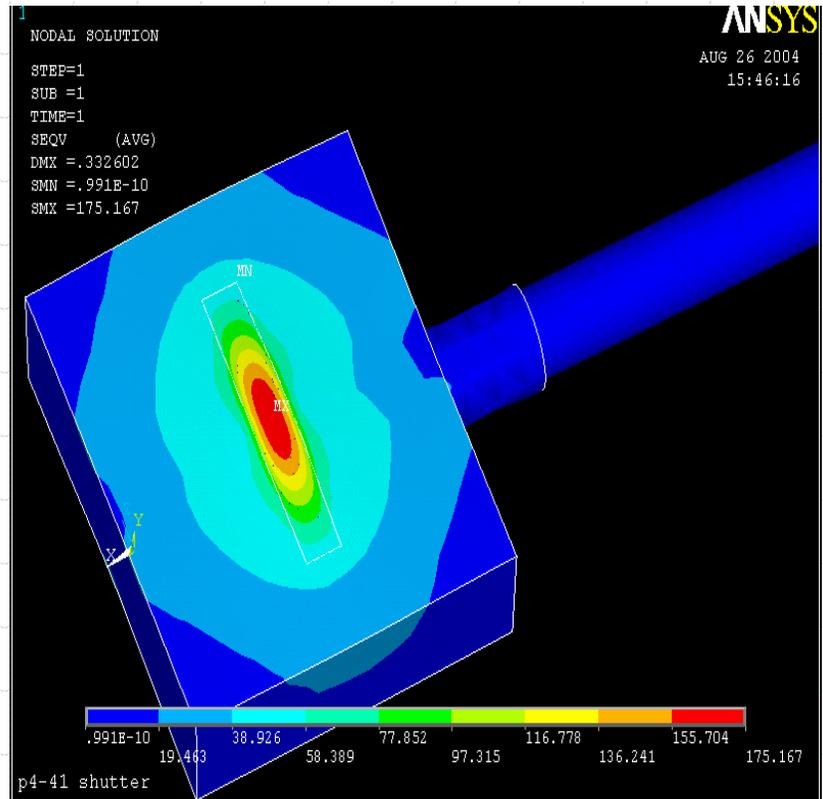


P4-40 FEA mesh

Results-contour plots for P4-40

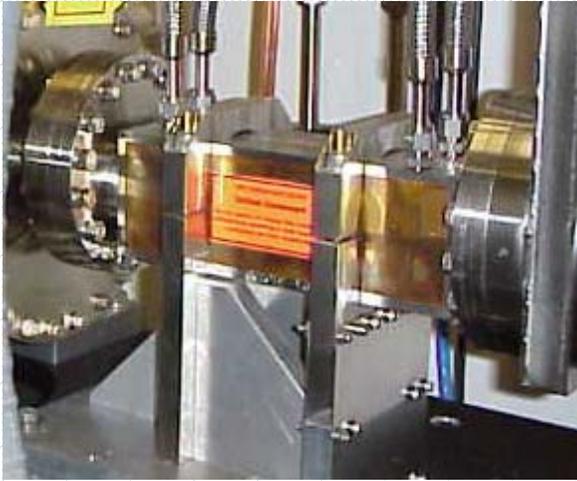


P4-40: Temperature Contours

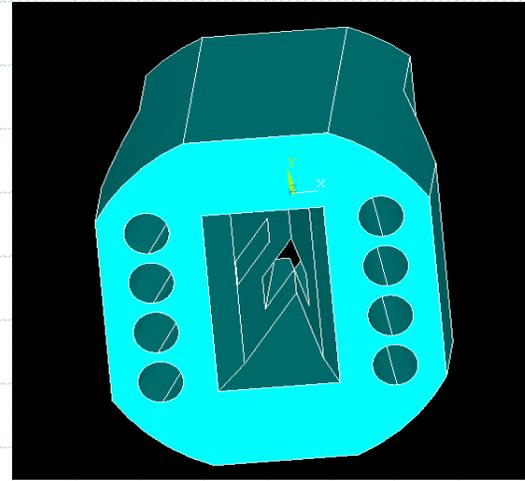


P4-40: von Mises stress Contours

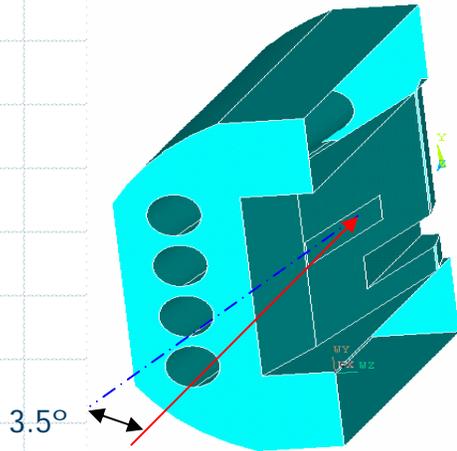
P4-50 Shutter



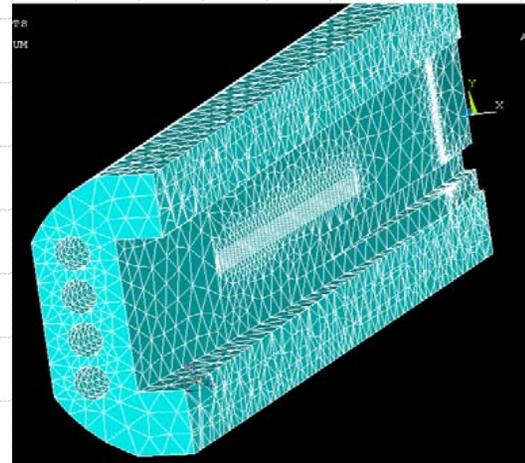
P4-50



P4-50 3-D model

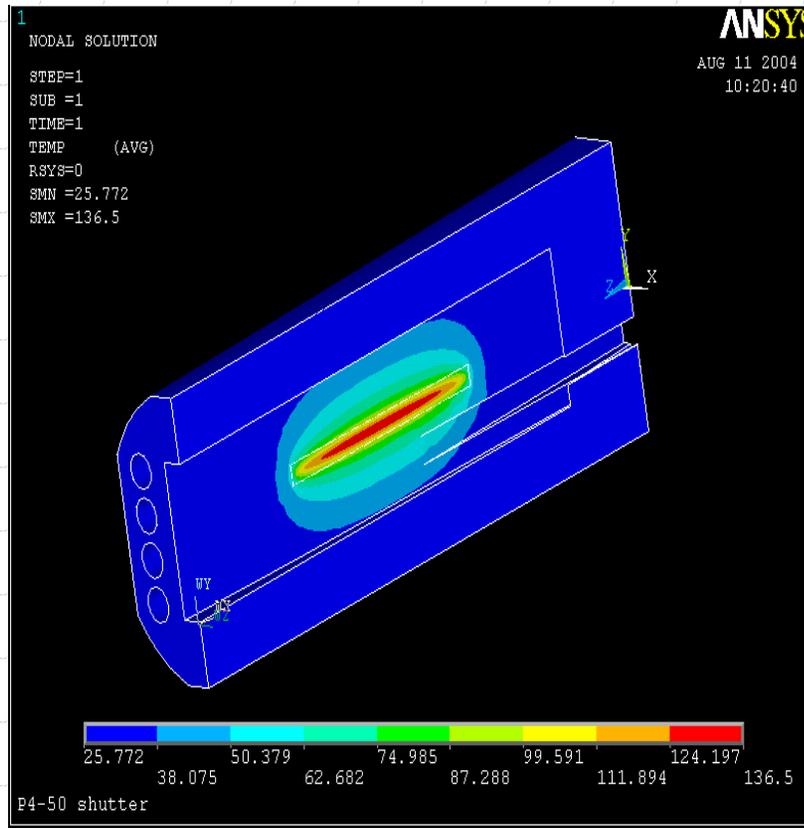


P4-50 Beam orientation

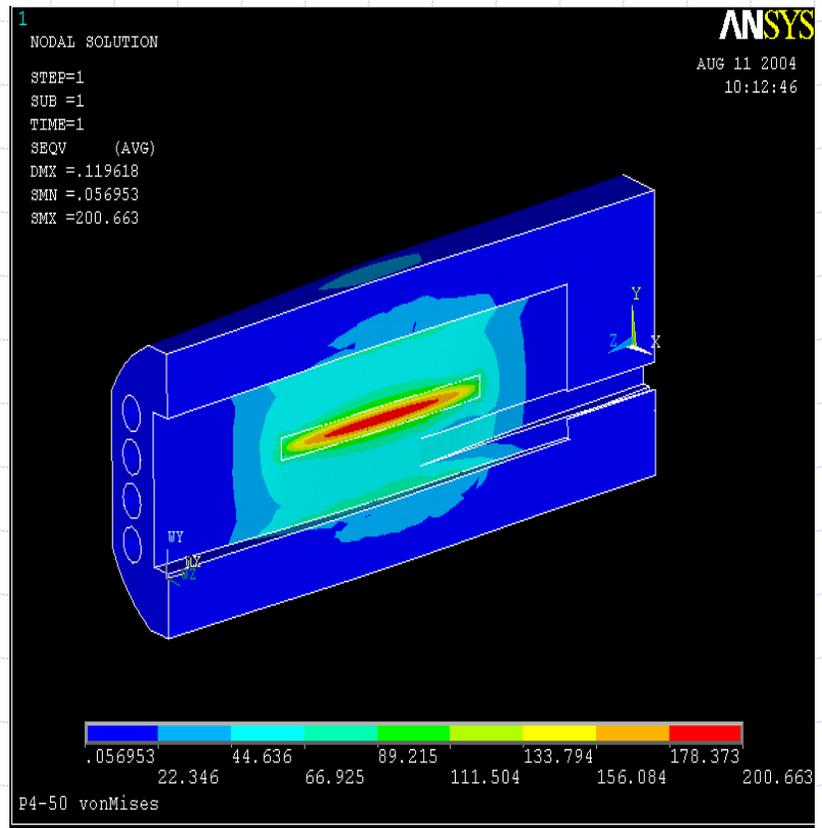


P4-50 FEA mesh

Results-contour plots for P4-50



P4-50: Temperature Contours



P4-50: von Mises Stress Contours

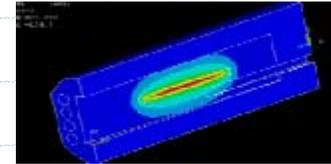
Results

Components	Temperature (°C)	von Mises Stress (MPa)	Channel Wall Temperature (°C)
Masks			
L5-83 front end exit mask	195	378	98
*M4-30 front end exit mask	96	151	55
*M4-40 front end exit mask	178	350	68
*M7-20 front end exit mask	156	274	68
M7-41 beamline splitter mask	172	240	73
M9-30 white beam stop and pink beam mask	210	285	80
Shutters			
P5 Integral Shutter	238	280	95
P4-20 shutter	144	183	84
P4-30 shutter	121	175	57
P4-41 white beam stop	186	175	94
P4-50 shutter	137	201	62
K5-50 white beam stop	175	312	135

Goal II: Fatigue Design Criteria

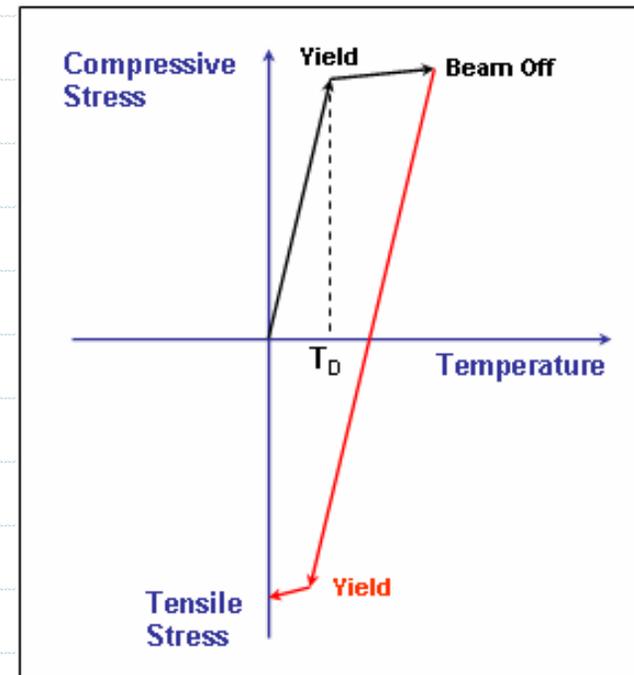
Linear elastic Analyses are not useful in determining beam current limit or for predicting fatigue life.

- Thermal stresses are generally compressive.
- Tensile stresses cause cracks and fatigue failure.
- Temperatures higher than T_D will cause yielding.
- Compressive plastic deformation will cause tensile stresses on unloading (beam off).

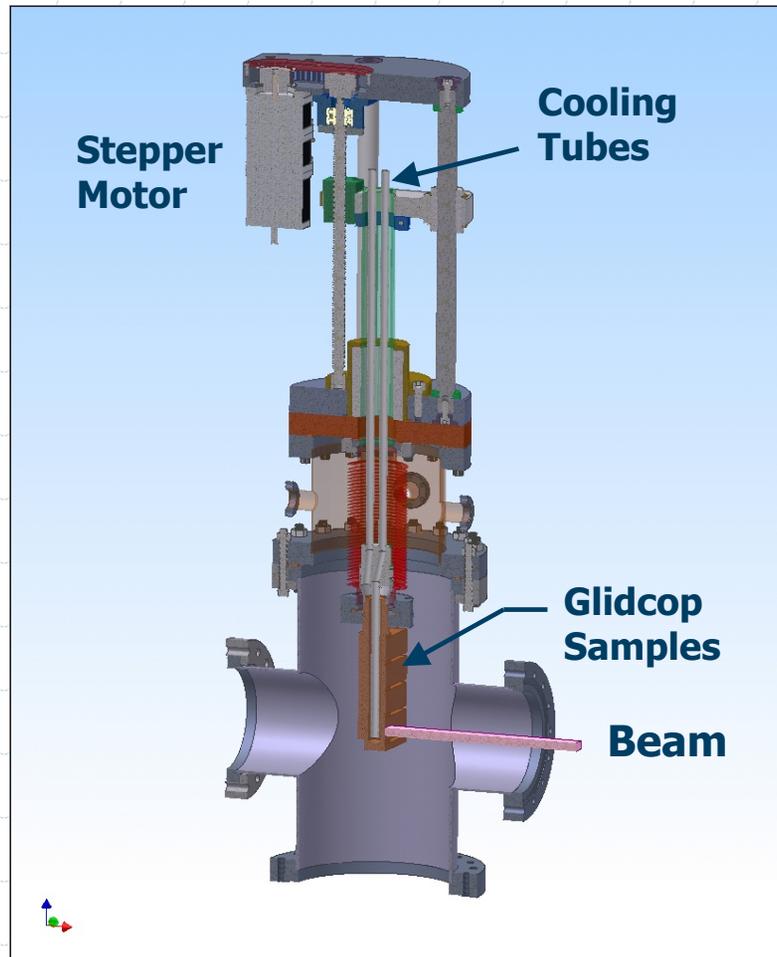


- A fatigue design committee was appointed:

Professor Michael Gosz (IIT), Yifei Jaski (XFD), Dr. Saurin Majumdar (ET-ANL)
Sushil Sharma (ASD, Chair), Dr. Lin Zhang (ESRF)
(new members, Carlos Segre, Dean Haeffner ?)



Fatigue Tests at ESRF



Test Setup (ME-ASD)

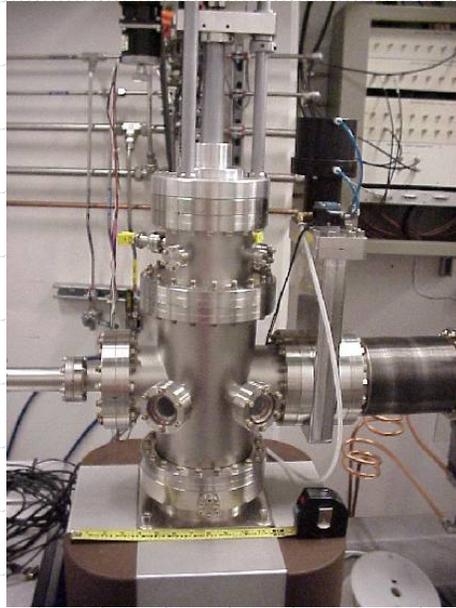


Beamline Hutch



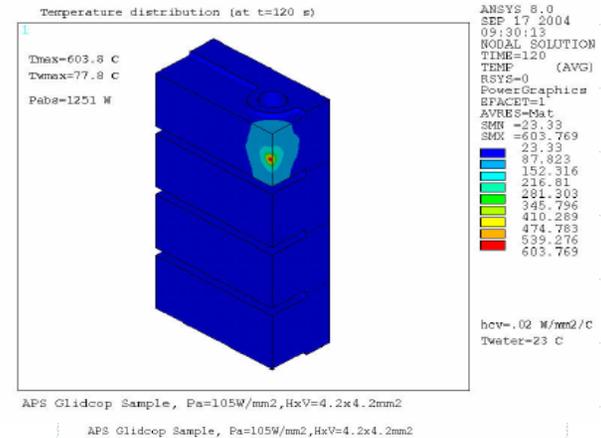
- Two U42 and one U34 undulators
- $P = 105 \text{ W/mm}^2$ (200 mA, 73 % absorption)
- Beam size = 4.2mm x 4.2mm
- Total absorbed power = 1251 W
- Max. Temperature = 604 °C

Fatigue Tests at ESRF – Temperature Cycles

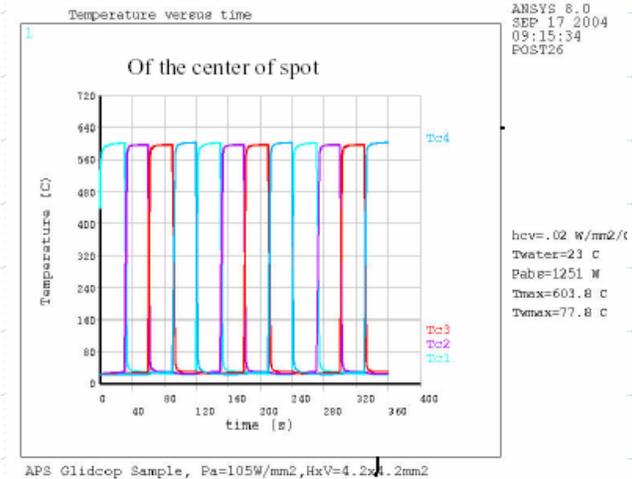


A sapphire window will allow IR imaging of the beam footprint.

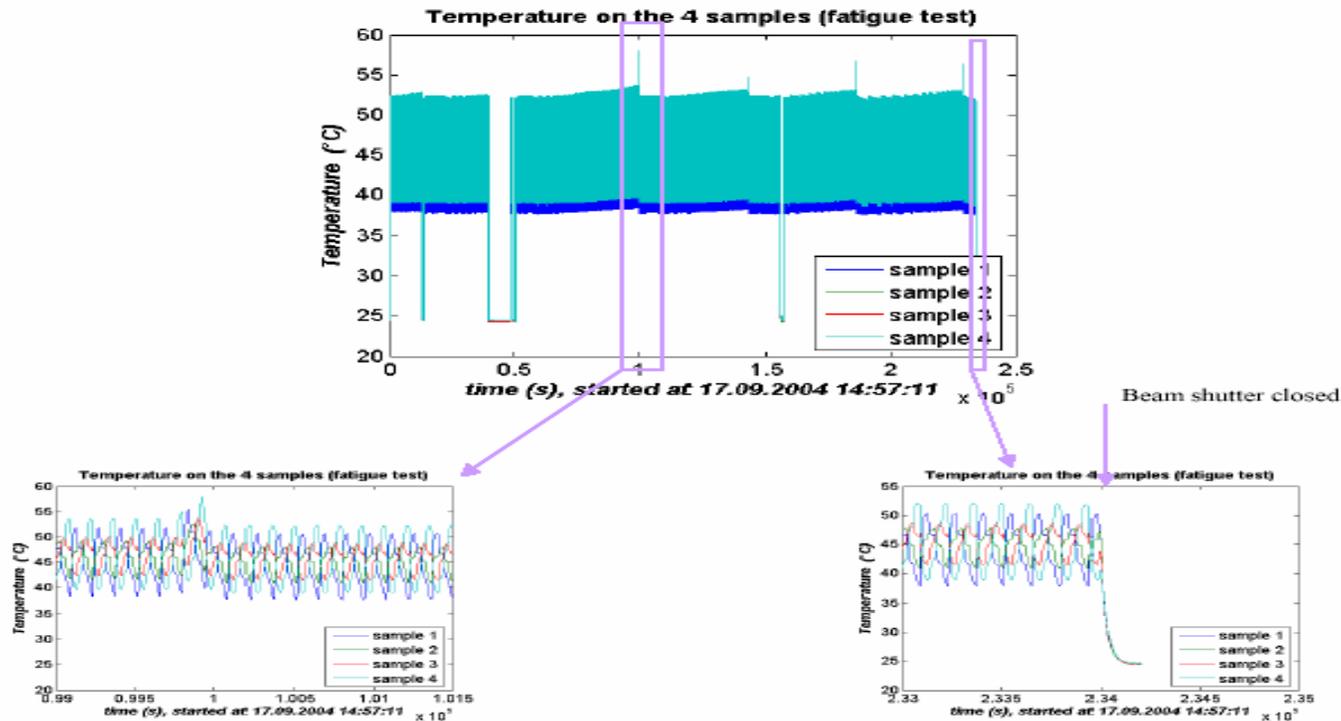
Temperatures were monitored with thermocouples attached at the sides of the samples.



Thermal Analysis

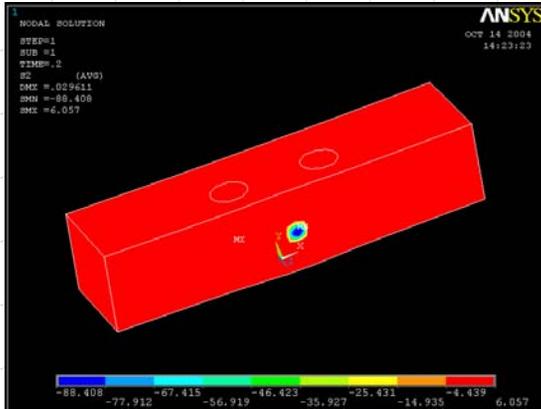


Fatigue Tests at ESRF – Temperature Cycles

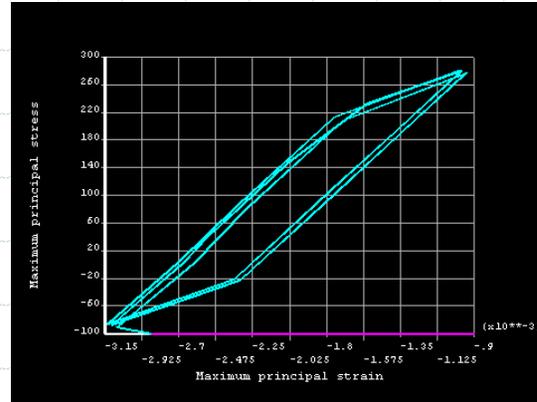


- **No change in vacuum pressure after 3,755 cycles.**
- **Peak temperature of ~ 600 °C at the center of beam footprint.**
- **Testing will continue in November for up to 10,000 cycles.**
- **An IR camera will be used for imaging thermal contours.**
- **Surface analysis of the samples will be performed.**

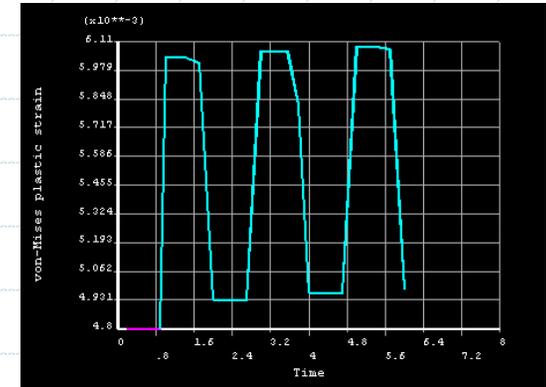
Fatigue Tests: Preliminary Thermal, Elastic-Plastic Analyses



Temperature Contours



Stress – Strain Cycles



Plastic Strain vs Time

- Thermal and Elastic-Plastic analyses are being performed both at APS and ESRF.
- Strain amplitude can be obtained from strain vs time graph.
- Fatigue life can be estimated by a simplified Coffin-Manson approach:

$$\Delta \epsilon / 2 = \epsilon_f' (2N_f)^c$$

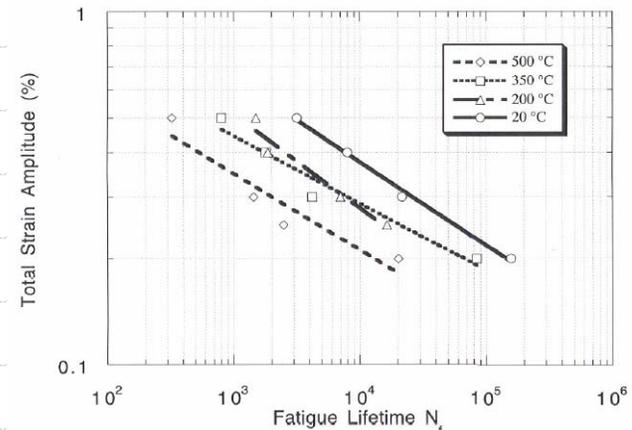
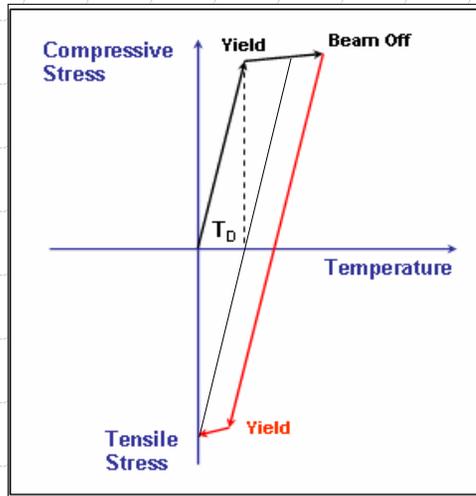


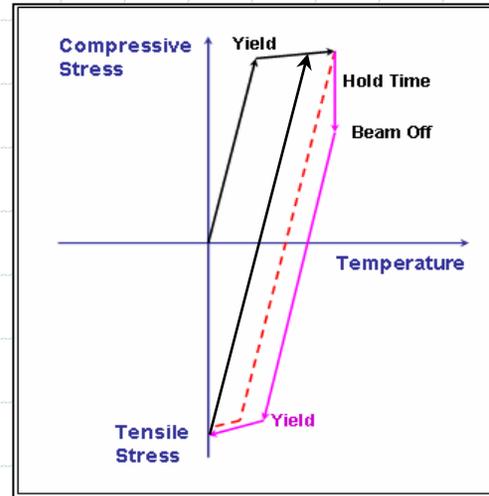
Fig. 8(a)

Li et al. , Metallurgical and Materials Trans. Vol. 31A (10), 2000

Fatigue Tests – Hold-Time (Stress Relaxation) Effect



Fatigue Test Cycles



Operational Cycles

- Hold-time (creep) effect may lead to higher tensile stresses.
- Further testing and analysis will be undertaken to determine this effect.

Fatigue Tests – Effect of Initial Yield Strength

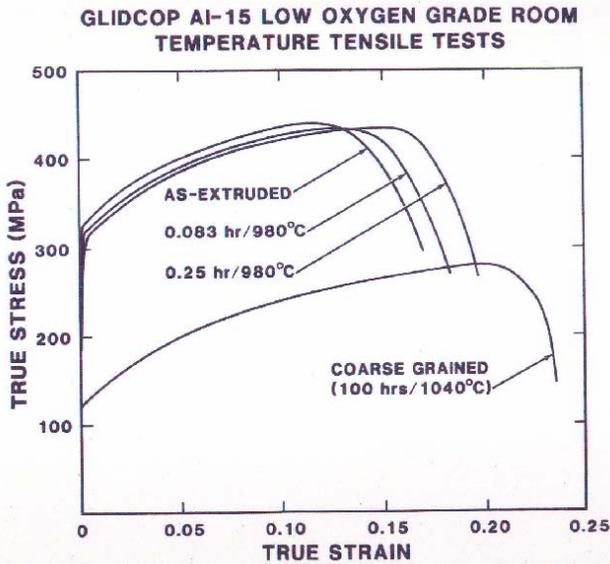


Fig. 5

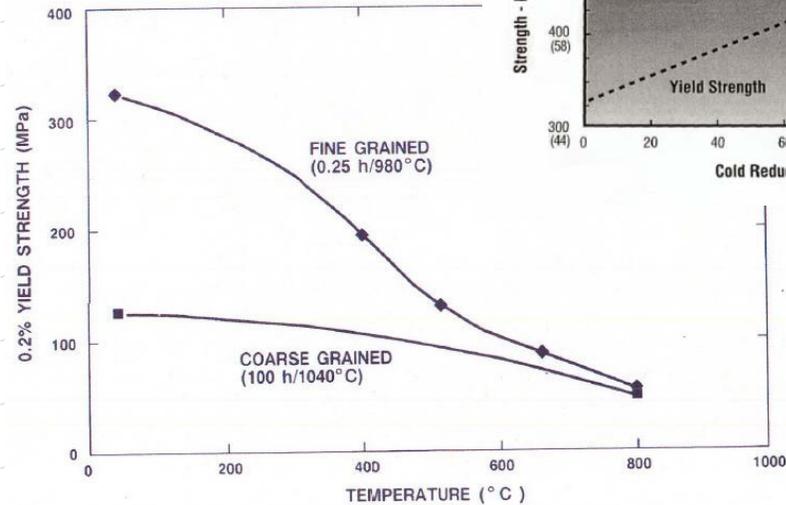
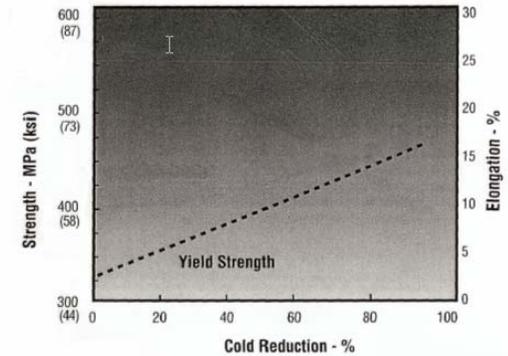


Fig. 20



"Comparison of strain rate: flow stress at 800 °C for the fine-grained, braze cycled material with coarse-grained, long term (100 hr. at 1040 °C) material, Figure 23, indicates that the coarse grained material is significantly stronger than the fine grained material. "

J. J. Stephens et al. SAND88 – 1351 (1988), pp. 15

Summary

- **Thermal analyses of beamline components identified by M. Ramanathan have been completed.**
- **Results show that conservative design criteria are met (with some exceptions, e.g. K5-50) for a beam current of ~ 140 mA.**
- **Fatigue tests (ongoing at ESRF) show that a maximum temperature limit of ~ 600 °C may be acceptable for a few thousand temperature cycles.**
- **High current runs of short durations appear to pose little risk (assuming no damage to Glidcop samples under fatigue testing at ESRF).**
- **Further fatigue tests and elastic-plastic analyses are planned to:**
 - (1) Correlate experimental and analytical data at different maximum temperatures.**
 - (2) Evaluate the effects of other factors such as stress relaxation and initial yield stress.**